

## Design of a 1.2V LDO for 1mA-25mA Load Range in 0.18 $\mu$ m CMOS

### Error Amplifier Architecture

The output impedance due to load regulation is approximately:

$$\text{Load Regulation} \approx \frac{r_{dsp}}{1 + T_0} \approx \frac{r_{dsp}}{A_{EA0} \cdot g_{mp} \cdot r_{dsp} \cdot \beta} = \frac{1}{A_{EA0} \cdot g_{mp} \cdot \beta}$$

To meet the specification:

$$\begin{aligned} \frac{1}{A_{EA0} \cdot g_{mp} \cdot \beta} &\leq 50 \mu\text{V}/\text{mA} = 0.05 \\ \Rightarrow A_{EA0} \cdot g_{mp} \cdot \beta &\geq 20 \end{aligned}$$

Given:

$$g_{mp} \approx 20 \text{ mS}, \quad \beta = \frac{2}{3} \Rightarrow A_{EA0} \cdot 20 \times 10^{-3} \cdot \frac{2}{3} \geq 20 \Rightarrow A_{EA0} \geq 1500$$

The line regulation is approximated by:

$$\begin{aligned} \text{Line Regulation} &\approx \frac{1}{A_{EA0} \cdot \beta} \leq 500 \mu\text{V}/\text{V} = 0.0005 \\ \Rightarrow A_{EA0} \cdot \beta &\geq 2000 \Rightarrow A_{EA0} \geq \frac{2000}{\beta} = \frac{2000}{2/3} = 3000 \end{aligned}$$

From both line and load regulation requirements, the minimum gain required is:

$$A_{EA0} \geq 3000 \quad (\approx 69.54 \text{ dB})$$

To ensure margin, a higher DC gain of approximately 90 dB was chosen. Since bandwidth was not a primary concern for this design, the tradeoff of lower speed for higher gain was acceptable.

To meet this high gain target while minimizing power and avoiding excess poles, a triple-cascode telescopic amplifier was selected as the error amplifier. This architecture was favored over folded cascode and multi-stage alternatives due to its superior gain efficiency and simplicity in compensation.

### Choosing Parameters

To achieve the required open-loop gain for the error amplifier, we use the gain expression for a triple-cascode amplifier:

$$A_{EA0} = \frac{1}{2}(g_m r_{ds})^3$$

Solving for  $A_{EA0} = 31622$ , we get:

$$g_m r_{ds} = \sqrt[3]{2A_{EA0}} = \sqrt[3]{63244} \approx 39.84$$

To ensure sufficient gain, this was rounded up:

$$g_m r_{ds} = 42$$

Based on this, we chose:

$$g_m = 80 \mu\text{S}, \quad r_{ds} = 525 \text{ k}\Omega$$

Since a triple-cascode topology was used, the drain voltage swing is limited. To maintain saturation with minimum  $v_{ds}$ , we selected a small  $\Delta = 0.1 \text{ V}$ . With:

$$v_{ds} = 0.2 \text{ V}, \quad \Delta = 0.1 \text{ V}$$

The transconductance and bias current relationship is:

$$g_m = \frac{2I_D}{\Delta} \Rightarrow I_D = \frac{g_m \cdot \Delta}{2} = \frac{80 \times 10^{-6} \cdot 0.1}{2} = 4 \mu\text{A}$$

For this bias current, the NMOS transistor width was chosen as:

$$W_{NMOS} = 6.03 \mu\text{m}$$

This sizing achieves the desired transconductance while keeping the device in saturation with appropriate headroom for cascoding.

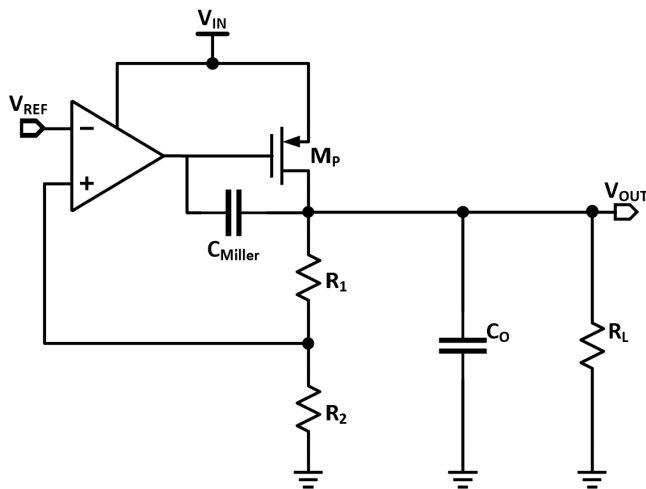


Figure 1: LDO schematic.

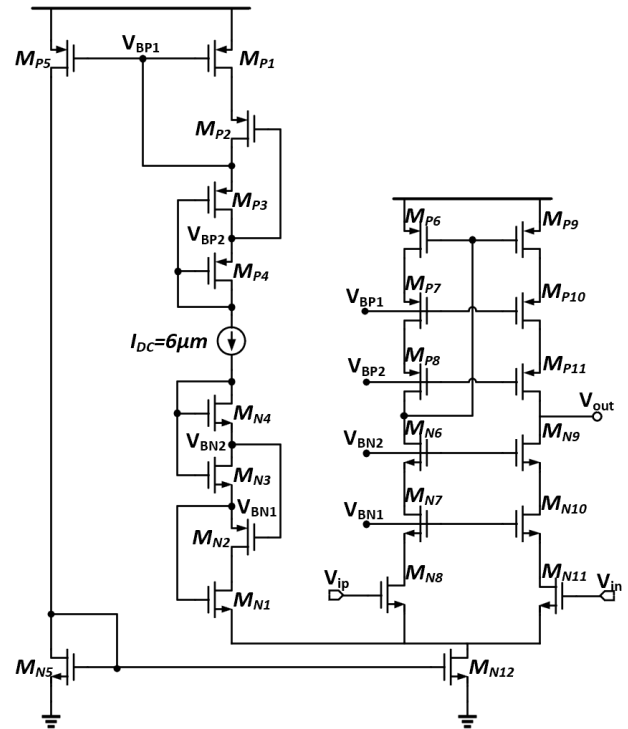


Figure 2: Error Amplifier Transistor-Level Schematic

### Pass Transistor Sizing:

To properly size the PMOS pass transistor for the target load current range of 1mA to 25mA, we began by setting both  $V_{gs}$  and  $V_{ds}$  to 0.9V, and perform a sweep of the PMOS transistor width. After narrowing down the suitable width range, we performed an additional sweep over  $V_{gs}$  to ensure that the chosen device would reliably conduct the required current across expected variations in gate voltage. Following these iterations, we selected a PMOS width of  $650 \mu\text{m}$  as it provided sufficient drive strength across the specified voltages and currents.

### Resistor Sizing

We selected a feedback ratio of  $\beta = \frac{2}{3}$ , where:

$$\beta = \frac{R_{F2}}{R_{F1} + R_{F2}}$$

To satisfy this ratio, we chose:

$$R_{F1} = 10 \text{ k}\Omega, \quad R_{F2} = 20 \text{ k}\Omega$$

These values are reasonable, as they set the feedback divider current to approximately  $40 \mu\text{A}$  when  $V_{OUT} = 1.2 \text{ V}$ , which is acceptable given the overall quiescent current budget, particularly under maximum load

conditions ( $I_L = 20 \text{ mA}$ ).

### Miller Capacitor Compensation

To ensure loop stability and achieve a phase margin (PM) close to  $60^\circ$ , Miller compensation was implemented. A compensation capacitor  $C_c$  was placed between the output of the error amplifier and an internal high-impedance node. This introduces a dominant pole at low frequency and pushes the non-dominant poles to higher frequencies through pole-splitting. To determine the optimal value of  $C_c$ , a parameter sweep was performed in simulation under the worst-case loading condition ( $I_L = 20 \text{ mA}$ )

Table 1: MOSFET Characteristics

Device	W	L	$g_m$	$r_{ds}$	$I_{ds}$	$\Delta$	Region of Operation
$M_{P1}$	540nm	360nm	$27.06\mu\text{S}$	$195.6\text{K}\Omega$	$-6\mu\text{A}$	$-284.4\text{mV}$	Linear
$M_{P2}$	$1.62\mu\text{m}$	360nm	$56.93\mu\text{S}$	$1.548\text{M}\Omega$	$-6\mu\text{A}$	$-172.4\text{mV}$	Saturation
$M_{P3}$	540nm	360nm	$17.78\mu\text{S}$	$49.53\text{K}\Omega$	$-6\mu\text{A}$	$-350.4\text{mV}$	Linear
$M_{P4}$	$1.62\mu\text{m}$	360nm	$55.28\mu\text{S}$	$1.869\text{M}\Omega$	$-6\mu\text{A}$	$-183.4\text{mV}$	Saturation
$M_{N1}$	360nm	360nm	$48.97\mu\text{S}$	$90.22\text{K}\Omega$	$6\mu\text{A}$	$167.8\text{mV}$	Linear
$M_{N2}$	810nm	360nm	$81.89\mu\text{S}$	$907.2\text{K}\Omega$	$6\mu\text{A}$	$120.1\text{mV}$	Saturation
$M_{N3}$	270nm	360nm	$29.69\mu\text{S}$	$31.4\text{K}\Omega$	$6\mu\text{A}$	$219.3\text{mV}$	Linear
$M_{N4}$	810nm	360nm	$83.13\mu\text{S}$	$943.5\text{K}\Omega$	$6\mu\text{A}$	$124.8\text{mV}$	Saturation
$M_{P5}$	$1.26\mu\text{m}$	360nm	$74.93\mu\text{S}$	$1.24\text{M}\Omega$	$-15.3\mu\text{A}$	$-284.3\text{mV}$	Saturation
$M_{N5}$	$6.03\mu\text{m}$	360nm	$279.8\mu\text{S}$	$288.7\text{K}\Omega$	$15.3\mu\text{A}$	$80.08\text{mV}$	Saturation
$M_{P6}$	$4.995\mu\text{m}$	495nm	$62.34\mu\text{S}$	$945.6\text{K}\Omega$	$-4.125\mu\text{A}$	$-103.3\text{mV}$	Saturation
$M_{P7}$	$4.995\mu\text{m}$	495nm	$61.74\mu\text{S}$	$598.6\text{K}\Omega$	$-4.125\mu\text{A}$	$-107.2\text{mV}$	Saturation
$M_{P8}$	$9\mu\text{m}$	540nm	$71.6\mu\text{S}$	$739.9\text{K}\Omega$	$-4.125\mu\text{A}$	$-90.44\text{mV}$	Saturation
$M_{P9}$	$4.995\mu\text{m}$	495nm	$62.34\mu\text{S}$	$945.8\text{K}\Omega$	$-4.125\mu\text{A}$	$-103.3\text{mV}$	Saturation
$M_{P10}$	$4.995\mu\text{m}$	495nm	$71.6\mu\text{S}$	$613.3\text{K}\Omega$	$-4.125\mu\text{A}$	$-107.1\text{mV}$	Saturation
$M_{P11}$	$9\mu\text{m}$	540nm	$72.38\mu\text{S}$	$1.89\text{M}\Omega$	$-4.125\mu\text{A}$	$-89.46\text{mV}$	Saturation
$M_{N6}$	$4.5\mu\text{m}$	540nm	$86.99\mu\text{S}$	$1.192\text{M}\Omega$	$4.125\mu\text{A}$	$68.93\text{mV}$	Saturation
$M_{N7}$	$4.005\mu\text{m}$	360nm	$88.67\mu\text{S}$	$186\text{K}\Omega$	$4.125\mu\text{A}$	$64.28\text{mV}$	Saturation
$M_{N8}$	$6.03\mu\text{m}$	360nm	$93.28\mu\text{S}$	$391.5\text{K}\Omega$	$4.125\mu\text{A}$	$56.59\text{mV}$	Saturation
$M_{N9}$	$4.5\mu\text{m}$	540nm	$87.04\mu\text{S}$	$1.162\text{M}\Omega$	$4.125\mu\text{A}$	$69.18\text{mV}$	Saturation
$M_{N10}$	$4.005\mu\text{m}$	360nm	$88.6\mu\text{S}$	$180\text{K}\Omega$	$4.125\mu\text{A}$	$64.31\text{mV}$	Saturation
$M_{N11}$	$6.03\mu\text{m}$	360nm	$93.28\mu\text{S}$	$391.2\text{K}\Omega$	$4.125\mu\text{A}$	$56.59\text{mV}$	Saturation
$M_{N12}$	$6.03\mu\text{m}$	360nm	$263.6\mu\text{S}$	$220.8\text{K}\Omega$	$14.25\mu\text{A}$	$79.1\text{mV}$	Saturation
$M_P$	$650\mu\text{m}$	180nm	-	-	-	-	-

Table 2: Performance summary

Design parameter/variable	Simulated performance	Specification
Input voltage	1.8V	$\leq 1.8\text{V}$
Output voltage	1.2V	$1.0\text{V} - 1.4\text{V}$
Load current	20mA	$1\text{mA} - 25\text{mA}$
DC load regulation	$0.022\mu\text{V}/\text{mA}$	$\leq 50\mu\text{V}/\text{mA}$
DC line regulation	$15.7\mu\text{V}/\text{V}$	$\leq 500\mu\text{V}/\text{V}$
Quiescent current ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$40\mu\text{A}/40\mu\text{A}$	Minimum
PSR (@ $F_{in} = 1\text{KHz}/F_{in} = 1\text{MHz}$ )	$-4.7\text{dB}/-61.8\text{dB}$ ( $I_L = 25\text{mA}$ )	—
Worst-case PSR	$-0.33\text{dB}$	—
DC loop gain ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$114.48\text{dB}/106.22\text{dB}$	—
Loop-gain unity gain frequency ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$1.185\text{MHz}/1.00135\text{MHz}$	—
Loop-gain phase margin ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$84.47^\circ/88.89^\circ$	—
Loop-gain gain margin ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$38.87\text{dB}/41.79\text{dB}$	—
Output noise ( $I_L = 1\text{mA}/I_L = 25\text{mA}$ )	$63.27\mu\text{V}/59.52\mu\text{V}$	—

## LOOP-GAIN AC RESPONSE

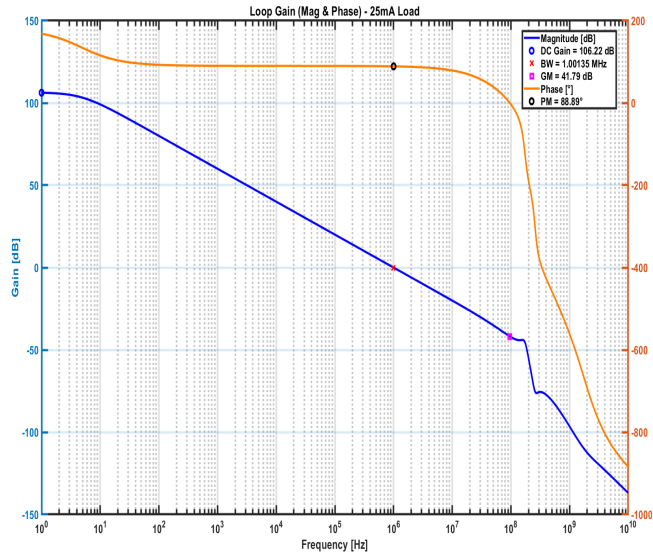


Figure 3: Loop Gain (at  $I_L = 25\text{mA}$ ) vs Freq

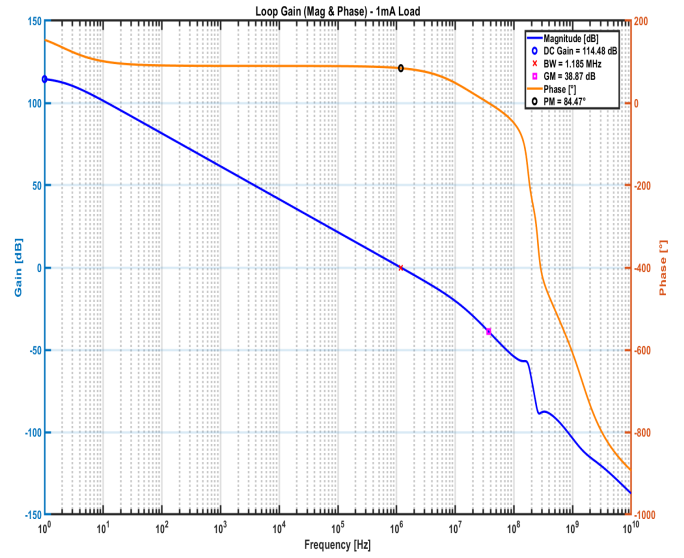


Figure 4: Loop Gain (at  $I_L = 1\text{mA}$ ) vs Freq

## DC LOAD AND LINE REGULATION RESPONSE

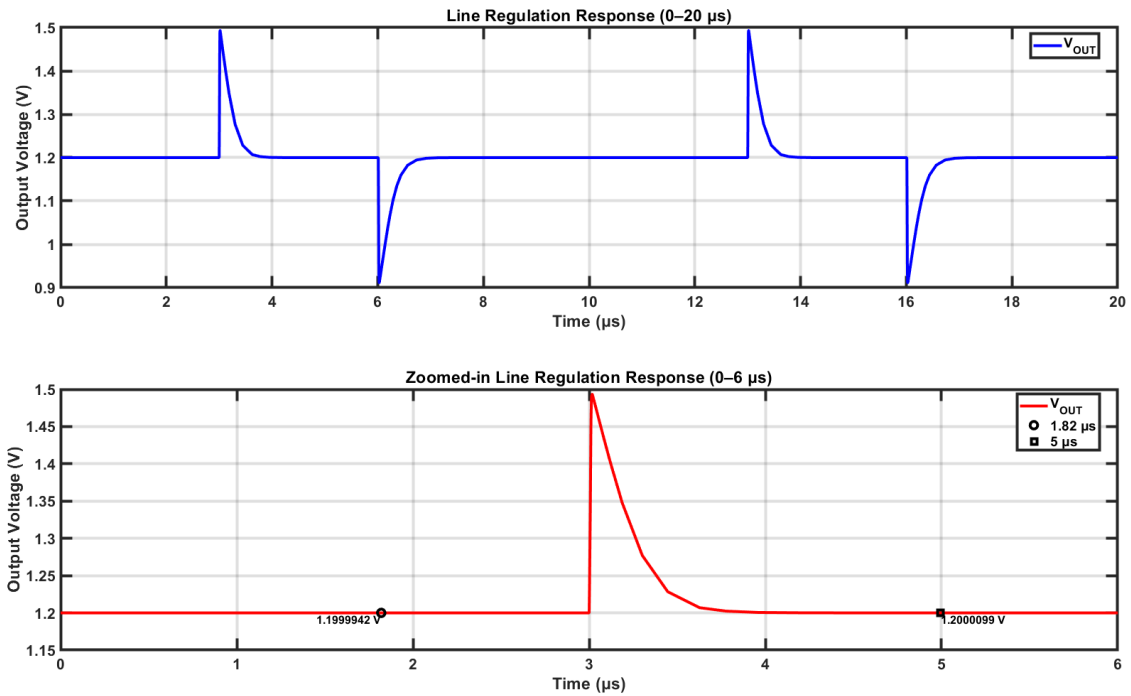


Figure 5: Line Regulation (at  $I_L = 20\text{mA}$ ) vs Time ( $\mu\text{s}$ ).

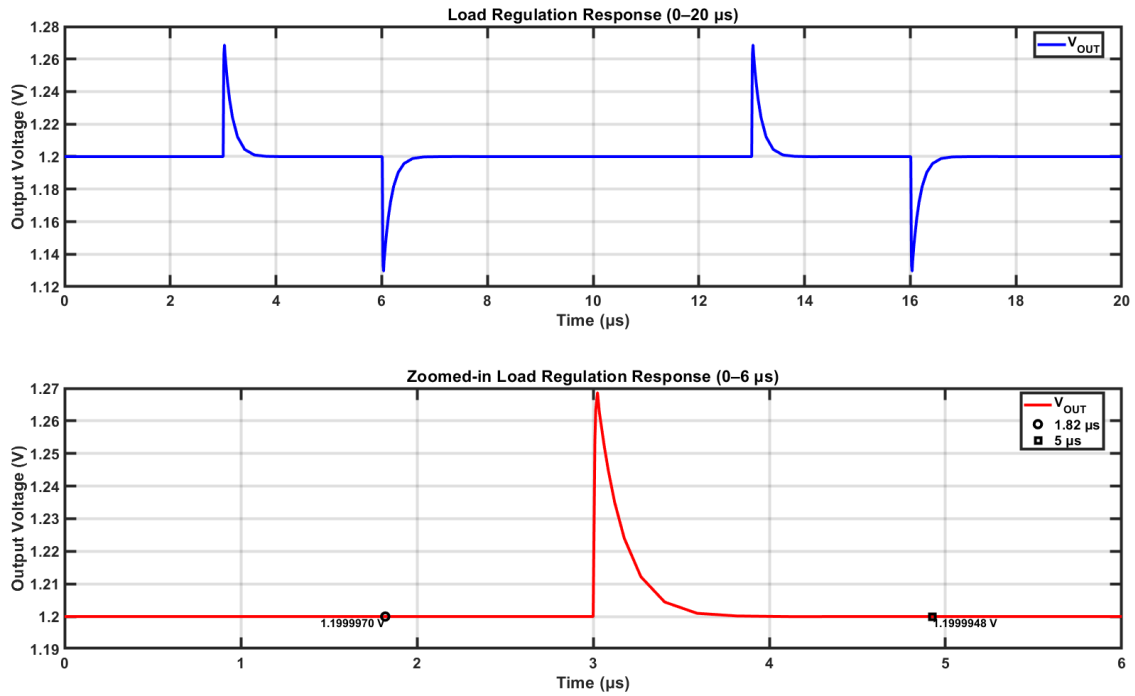


Figure 6: Load Regulation (at  $I_L = 20\text{mA}$ ) vs Time ( $\mu$  s).

## POWER SUPPLY REJECTION AND OUTPUT NOISE

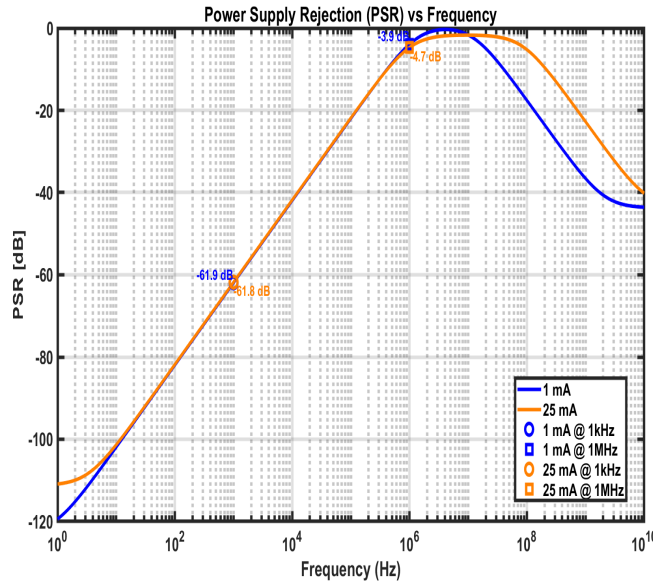


Figure 7: Power Supply Rejection (PSR) ( $I_L = 1\text{mA}$  /  $25\text{mA}$ ) vs Frequency

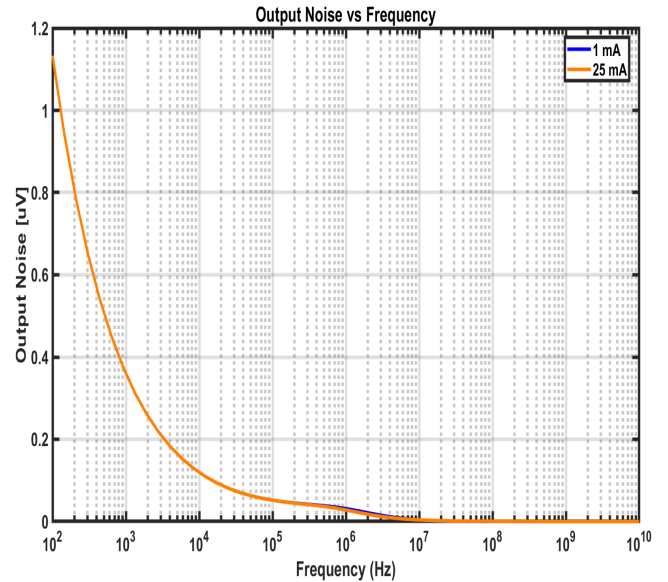


Figure 8: Output Noise ( $I_L = 1\text{mA}$  /  $25\text{mA}$ ) vs Frequency